

# SN54ABT162500, SN74ABT162500 18-BIT UNIVERSAL BUS TRANSCEIVERS WITH 3-STATE OUTPUTS

SCBS242E – JUNE 1992 – REVISED FEBRUARY 1999

- Members of the Texas Instruments *Widebus*™ Family
- B-Port Outputs Have Equivalent 25-Ω Series Resistors, So No External Resistors Are Required
- State-of-the-Art *EPIC-II B*™ BiCMOS Design Significantly Reduces Power Dissipation
- *UBT*™ (Universal Bus Transceiver) Combines D-Type Latches and D-Type Flip-Flops for Operation in Transparent, Latched, or Clocked Mode
- Typical  $V_{OLP}$  (Output Ground Bounce) < 0.8 V at  $V_{CC} = 5$  V,  $T_A = 25^\circ\text{C}$
- High-Impedance State During Power Up and Power Down
- Flow-Through Architecture Optimizes PCB Layout
- Latch-Up Performance Exceeds 500 mA Per JESD 17
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model ( $C = 200$  pF,  $R = 0$ )
- Package Options Include Plastic Shrink Small-Outline (DL) Package and 380-mil Fine-Pitch Ceramic Flat (WD) Package Using 25-mil Center-to-Center Spacings

## description

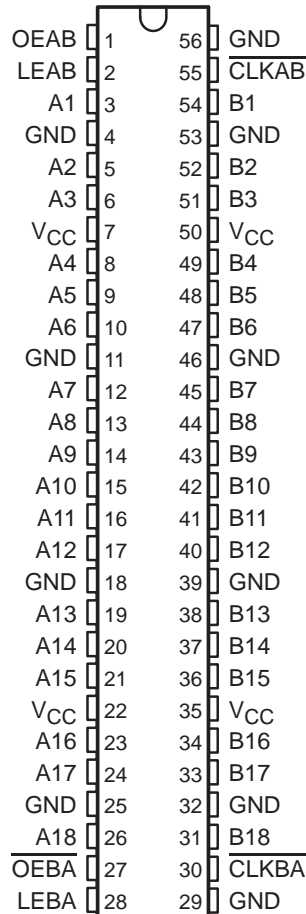
These 18-bit universal bus transceivers combine D-type latches and D-type flip-flops to allow data flow in transparent, latched, and clocked modes. Data flow in each direction is controlled by output-enable (OEAB and  $\overline{\text{OEBA}}$ ), latch-enable ( $\overline{\text{LEAB}}$  and LEBA), and clock ( $\overline{\text{CLKAB}}$  and  $\overline{\text{CLKBA}}$ ) inputs.

For A-to-B data flow, the device operates in the transparent mode when LEAB is high. When LEAB is low, the A data is latched if  $\overline{\text{CLKAB}}$  is held at a high or low logic level. If LEAB is low, the A data is stored in the latch/flip-flop on the high-to-low transition of  $\overline{\text{CLKAB}}$ . Output-enable OEAB is active high. When OEAB is high, the outputs are active. When OEAB is low, the outputs are in the high-impedance state.

Data flow for B to A is similar to that of A to B but uses  $\overline{\text{OEBA}}$ , LEBA, and  $\overline{\text{CLKBA}}$ . The output enables are complementary (OEAB is active high and  $\overline{\text{OEBA}}$  is active low).

The B-port outputs, which are designed to source or sink up to 12 mA, include equivalent 25-Ω series resistors to reduce overshoot and undershoot.

SN54ABT162500 . . . WD PACKAGE  
SN74ABT162500 . . . DL PACKAGE  
(TOP VIEW)



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 **TEXAS  
INSTRUMENTS**

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# SN54ABT162500, SN74ABT162500

## 18-BIT UNIVERSAL BUS TRANSCEIVERS

### WITH 3-STATE OUTPUTS

SCBS242E – JUNE 1992 – REVISED FEBRUARY 1999

#### description (continued)

When  $V_{CC}$  is between 0 and 2.1 V, the device is in the high-impedance state during power up or power down. However, to ensure the high-impedance state above 2.1 V,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor and OE should be tied to GND through a pulldown resistor; the minimum value of the resistor is determined by the current-sinking/current-sourcing capability of the driver.

The SN54ABT162500 is characterized for operation over the full military temperature range of  $-55^{\circ}\text{C}$  to  $125^{\circ}\text{C}$ . The SN74ABT162500 is characterized for operation from  $-40^{\circ}\text{C}$  to  $85^{\circ}\text{C}$ .

FUNCTION TABLE†

INPUTS				OUTPUT
OEAB	LEAB	$\overline{\text{CLKAB}}$	A	B
L	X	X	X	Z
H	H	X	L	L
H	H	X	H	H
H	L	↓	L	L
H	L	↓	H	H
H	L	H	X	$B_0^{\ddagger}$
H	L	L	X	$B_0^{\S}$

† A-to-B data flow is shown: B-to-A flow is similar but uses  $\overline{\text{OEBA}}$ ,  $\overline{\text{LEBA}}$ , and  $\overline{\text{CLKBA}}$ .

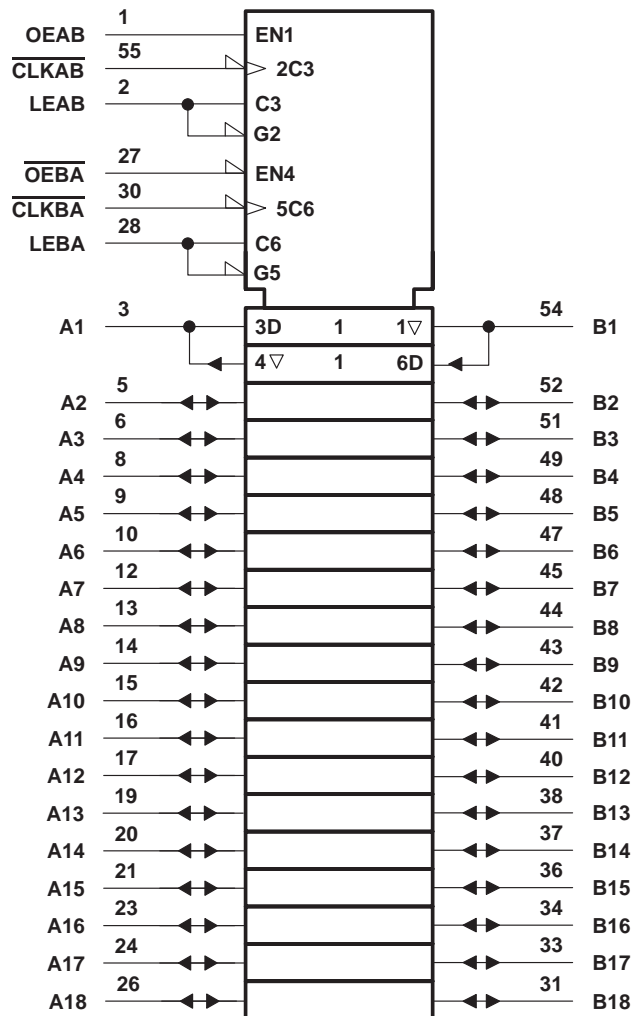
‡ Output level before the indicated steady-state input conditions were established

§ Output level before the indicated steady-state input conditions were established, provided that  $\overline{\text{CLKAB}}$  was low before LEAB went low

# SN54ABT162500, SN74ABT162500 18-BIT UNIVERSAL BUS TRANSCEIVERS WITH 3-STATE OUTPUTS

SCBS242E – JUNE 1992 – REVISED FEBRUARY 1999

logic symbol†

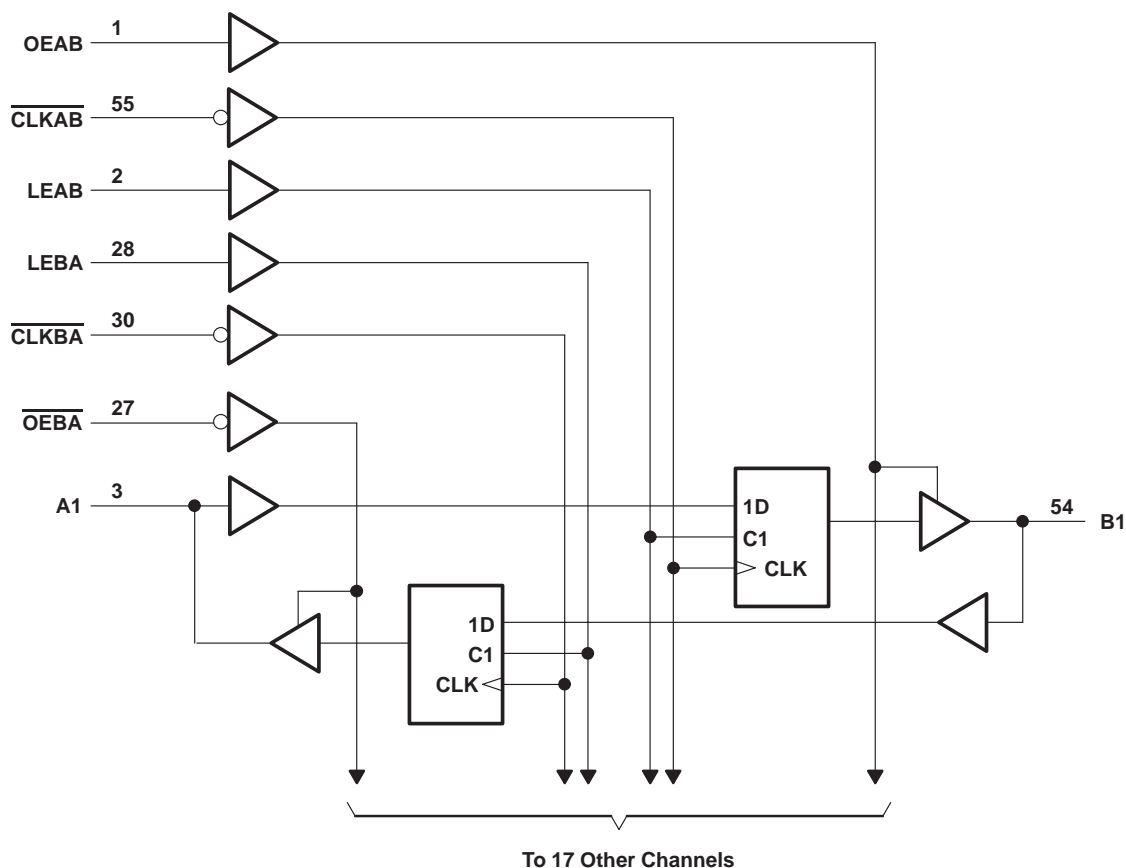


† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

# SN54ABT162500, SN74ABT162500 18-BIT UNIVERSAL BUS TRANSCEIVERS WITH 3-STATE OUTPUTS

SCBS242E – JUNE 1992 – REVISED FEBRUARY 1999

## logic diagram (positive logic)



## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, $V_{CC}$ .....	-0.5 V to 7 V
Input voltage range, $V_I$ (except I/O ports) (see Note 1) .....	-0.5 V to 7 V
Voltage range applied to any output in the high or power-off state, $V_O$ .....	-0.5 V to 5.5 V
Current into any output in the low state, $I_O$ : SN54ABT162500 (A port) .....	96 mA
SN74ABT162500 (A port) .....	128 mA
B port .....	30 mA
Input clamp current, $I_{IK}$ ( $V_I < 0$ ) .....	-18 mA
Output clamp current, $I_{OK}$ ( $V_O < 0$ ) .....	-50 mA
Package thermal impedance, $\theta_{JA}$ (see Note 2): DL package .....	74°C/W
Storage temperature range, $T_{stg}$ .....	-65°C to 150°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.  
2. The package thermal impedance is calculated in accordance with JESD 51.



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# SN54ABT162500, SN74ABT162500 18-BIT UNIVERSAL BUS TRANSCEIVERS WITH 3-STATE OUTPUTS

SCBS242E – JUNE 1992 – REVISED FEBRUARY 1999

## recommended operating conditions (see Note 3)

		SN54ABT162500		SN74ABT162500		UNIT
		MIN	MAX	MIN	MAX	
V <sub>CC</sub>	Supply voltage	4.5	5.5	4.5	5.5	V
V <sub>IH</sub>	High-level input voltage	2		2		V
V <sub>IL</sub>	Low-level input voltage		0.8		0.8	V
V <sub>I</sub>	Input voltage	0	V <sub>CC</sub>	0	V <sub>CC</sub>	V
I <sub>OH</sub>	High-level output current	A port		–32		mA
		B port		–12		
I <sub>OL</sub>	Low-level output current	A port		64		mA
		B port		12		
Δt/Δv	Input transition rise or fall rate	Outputs enabled		10		ns/V
Δt/ΔV <sub>CC</sub>	Power-up ramp rate	200		200		μs/V
T <sub>A</sub>	Operating free-air temperature	–55	125	–40	85	°C

NOTE 3: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

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# SN54ABT162500, SN74ABT162500 18-BIT UNIVERSAL BUS TRANSCEIVERS WITH 3-STATE OUTPUTS

SCBS242E – JUNE 1992 – REVISED FEBRUARY 1999

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	$T_A = 25^\circ\text{C}$			SN54ABT162500		SN74ABT162500		UNIT	
		MIN	TYP†	MAX	MIN	MAX	MIN	MAX		
$V_{IK}$	$V_{CC} = 4.5\text{ V}$ , $I_I = -18\text{ mA}$			-1.2		-1.2		-1.2	V	
$V_{OH}$	A port	$V_{CC} = 4.5\text{ V}$ , $I_{OH} = -3\text{ mA}$	2.5		2.5		2.5		V	
		$V_{CC} = 5\text{ V}$ , $I_{OH} = -3\text{ mA}$	3		3		3			
	$V_{CC} = 4.5\text{ V}$	$I_{OH} = -24\text{ mA}$	2		2					
		$I_{OH} = -32\text{ mA}$	2*				2			
	B port	$V_{CC} = 4.5\text{ V}$ , $I_{OH} = -1\text{ mA}$	3.35		3.3		3.35			
		$V_{CC} = 5\text{ V}$ , $I_{OH} = -1\text{ mA}$	3.85		3.8		3.85			
$V_{CC} = 4.5\text{ V}$		$I_{OH} = -3\text{ mA}$	3.1		3		3.1			
		$I_{OH} = -12\text{ mA}$	2.6				2.6			
$V_{OL}$	A port	$V_{CC} = 4.5\text{ V}$	$I_{OL} = 48\text{ mA}$		0.55		0.55		V	
			$I_{OL} = 64\text{ mA}$		0.55*		0.55			
	B port	$V_{CC} = 4.5\text{ V}$ , $I_{OL} = 12\text{ mA}$		0.8		0.8		0.8		
$V_{hys}$			100					mV		
$I_I$	Control inputs	$V_{CC} = 0\text{ to }5.5\text{ V}$ , $V_I = V_{CC}\text{ or GND}$		$\pm 1$		$\pm 1$		$\pm 1$	$\mu\text{A}$	
	A or B ports	$V_{CC} = 2.1\text{ V to }5.5\text{ V}$ , $V_I = V_{CC}\text{ or GND}$		$\pm 20$		$\pm 20$		$\pm 20$		
$I_{OZPU}$	$V_{CC} = 0\text{ to }2.1\text{ V}$ , $V_O = 0.5\text{ V to }2.7\text{ V}$ , $\overline{OE}$ or $OE = X\text{S}$			$\pm 50$		$\pm 50$		$\pm 50$	$\mu\text{A}$	
$I_{OZPD}$	$V_{CC} = 2.1\text{ V to }0$ , $V_O = 0.5\text{ V to }2.7\text{ V}$ , $\overline{OE}$ or $OE = X\text{S}$			$\pm 50$		$\pm 50$		$\pm 50$	$\mu\text{A}$	
$I_{OZH}\ddagger$	$V_{CC} = 2.1\text{ V to }5.5\text{ V}$ , $V_O = 2.7\text{ V}$ , $\overline{OE} \geq 2\text{ V}$ or $OE \leq 0.8\text{ V}$			10		10		10	$\mu\text{A}$	
$I_{OZL}\ddagger$	$V_{CC} = 2.1\text{ V to }5.5\text{ V}$ , $V_O = 0.5\text{ V}$ , $\overline{OE} \geq 2\text{ V}$ or $OE \leq 0.8\text{ V}$			-10		-10		-10	$\mu\text{A}$	
$I_{off}$	$V_{CC} = 0$ , $V_I$ or $V_O \leq 4.5\text{ V}$			$\pm 100$				$\pm 100$	$\mu\text{A}$	
$I_{CEX}$	$V_{CC} = 5.5\text{ V}$ , $V_O = 5.5\text{ V}$	Outputs high		50		50		50	$\mu\text{A}$	
$I_{O}\parallel$	A port	$V_{CC} = 5.5\text{ V}$ , $V_O = 2.5\text{ V}$	-50	-110	-180	-50	-180	-50	-180	mA
	B port		-25	-55	-90	-25	-90	-25	-90	
$I_{CC}$	A or B ports	$V_{CC} = 5.5\text{ V}$ , $I_O = 0$ , $V_I = V_{CC}\text{ or GND}$	Outputs high		3		3		3	mA
			Outputs low		36		36		36	
			Outputs disabled		3		3		3	
$\Delta I_{CC}\#$	$V_{CC} = 5.5\text{ V}$ , One input at $3.4\text{ V}$ , Other inputs at $V_{CC}$ or $GND$			50		50		50	$\mu\text{A}$	
$C_i$	Control inputs	$V_I = 2.5\text{ V or }0.5\text{ V}$		3					pF	
$C_{io}$	A or B ports	$V_O = 2.5\text{ V or }0.5\text{ V}$		9					pF	

\* On products compliant to MIL-PRF-38535, this parameter does not apply.

† All typical values are at  $V_{CC} = 5\text{ V}$ .

‡ The parameters  $I_{OZH}$  and  $I_{OZL}$  include the input leakage current.

§ For  $V_{CC}$  between  $2.1\text{ V}$  and  $4\text{ V}$ ,  $OE$  should be less than or equal to  $0.5\text{ V}$  to ensure a low state.

¶ Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

# This is the increase in supply current for each input that is at the specified TTL voltage level rather than  $V_{CC}$  or  $GND$ .

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SCBS242E – JUNE 1992 – REVISED FEBRUARY 1999

timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

		SN54ABT162500		SN74ABT162500		UNIT
		MIN	MAX	MIN	MAX	
$f_{\text{clock}}$	Clock frequency	150		150		MHz
$t_w$	Pulse duration	$\overline{\text{LEAB}}$ or $\overline{\text{LEBA}}$ high		2.5		ns
		$\overline{\text{CLKAB}}$ or $\overline{\text{CLKBA}}$ high or low		3		
$t_{\text{su}}$	Setup time	A before $\overline{\text{CLKAB}}\downarrow$		3.3		ns
		B before $\overline{\text{CLKBA}}\downarrow$		3.3		
		A before $\overline{\text{LEAB}}\downarrow$ or B before $\overline{\text{LEBA}}\downarrow$	$\overline{\text{CLK}}$ high	1		
			$\overline{\text{CLK}}$ low	2.5		
$t_h$	Hold time	A after $\overline{\text{CLKAB}}\downarrow$ or B after $\overline{\text{CLKBA}}\downarrow$		0		ns
		A after $\overline{\text{LEAB}}\downarrow$ or B after $\overline{\text{LEBA}}\downarrow$		2		

switching characteristics over recommended ranges of supply voltage and operating free-air temperature,  $C_L = 50$  pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC} = 5$ V, $T_A = 25^\circ\text{C}$			SN54ABT162500		SN74ABT162500		UNIT
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
$f_{\text{max}}$			150	200		150		150		MHz
$t_{\text{PLH}}$	A or B	B or A	1.5	2.6	4	1.5	5.1	1.5	4.8	ns
$t_{\text{PHL}}$			2	3.4	5.2	2	6.1	2	5.7	
$t_{\text{PLH}}$	$\overline{\text{LEAB}}$ or $\overline{\text{LEBA}}$	B or A	2	3.3	4.8	2	6.1	2	5.6	ns
$t_{\text{PHL}}$			2	3.8	5.2	2	6.4	2	5.9	
$t_{\text{PLH}}$	$\overline{\text{CLKAB}}$ or $\overline{\text{CLKBA}}$	B or A	1.5	3.7	4.9	1.5	6.4	1.5	5.9	ns
$t_{\text{PHL}}$			1.5	3.8	5.2	1.5	6.4	1.5	6	
$t_{\text{PZH}}$	$\overline{\text{OEAB}}$ or $\overline{\text{OEBA}}$	B or A	1.5	3.4	4.6	1.5	5.6	1.5	5.3	ns
$t_{\text{PZL}}$			2	3.8	4.7	2	5.6	2	5.4	
$t_{\text{PHZ}}$	$\overline{\text{OEAB}}$ or $\overline{\text{OEBA}}$	B or A	2	4.5	5.7	2	6.9	2	6.5	ns
$t_{\text{PLZ}}$			1.5	3.8	5.3	1.5	6.3	1.5	5.8	

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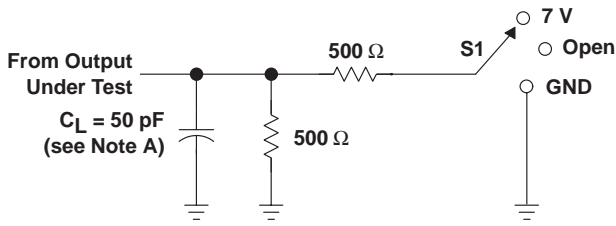


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**WITH 3-STATE OUTPUTS**

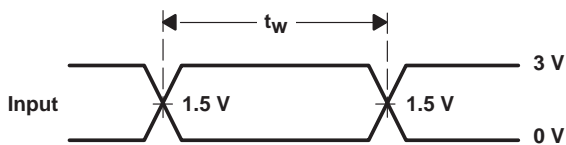
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**PARAMETER MEASUREMENT INFORMATION**

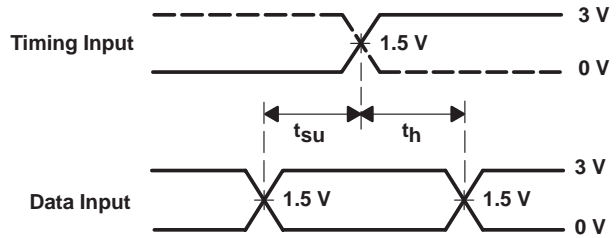


TEST	S1
$t_{PLH}/t_{PHL}$	Open
$t_{PLZ}/t_{PZL}$	7 V
$t_{PHZ}/t_{PZH}$	Open

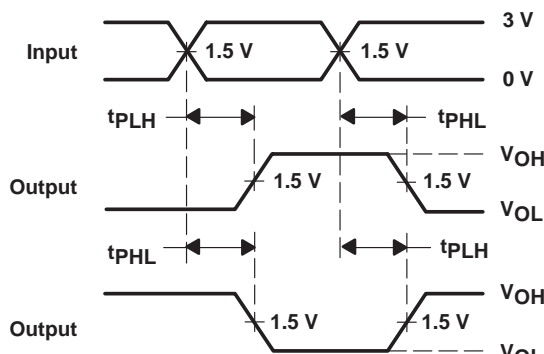
**LOAD CIRCUIT**



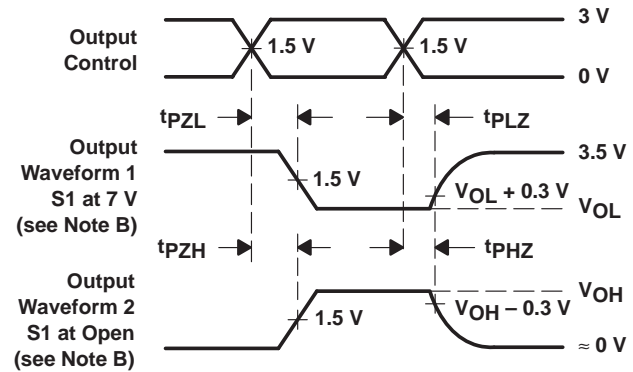
**VOLTAGE WAVEFORMS**  
**PULSE DURATION**



**VOLTAGE WAVEFORMS**  
**SETUP AND HOLD TIMES**



**VOLTAGE WAVEFORMS**  
**PROPAGATION DELAY TIMES**  
**INVERTING AND NONINVERTING OUTPUTS**



**VOLTAGE WAVEFORMS**  
**ENABLE AND DISABLE TIMES**  
**LOW- AND HIGH-LEVEL ENABLING**

- NOTES: A.  $C_L$  includes probe and jig capacitance.  
 B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.  
 C. All input pulses are supplied by generators having the following characteristics:  $PRR \leq 10$  MHz,  $Z_O = 50 \Omega$ ,  $t_r \leq 2.5$  ns,  $t_f \leq 2.5$  ns.  
 D. The outputs are measured one at a time with one transition per measurement.

**Figure 1. Load Circuit and Voltage Waveforms**





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